

Exploration of Activation Fault Reliability in Quantized Systolic Array-Based DNN Accelerators

Taheri, Mahdi; Cherezova, Natalia; Ansari, Mohammad Saeed; **Jenihhin, Maksim;** Mahani, Ali; **Daneshtalab, Masoud; Raik, Jaan** 25th International Symposium on Quality Electronic Design (ISQED) 2025 / 8 p. : ill <https://ieeexplore.ieee.org/stamp/stamp.jsp?arnumber=10528372>

A systematic literature review on hardware reliability assessment methods for deep neural networks

Ahmadilivani, Mohammad Hasan; Taheri, Mahdi; Raik, Jaan; Daneshtalab, Masoud; Jenihhin, Maksim ACM Computing Surveys 2024 / art. 141, 39 p. : ill <https://doi.org/10.1145/3638242> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)